

## Notice of References Cited

Application/Control No.	Applicant(s)/Pate Reexamination	nt Under
 09/772,756	Reexamination NAFIE ET AL.	· # .
Examiner	Art Unit	
Betsy L. Deppe	2634	Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-2002/0057726 A1	05-2002	Williams et al.	375/136
	В	US-6,577,670 B1	06-2003	Roberts, Richard D.	375/133
	С	US-			
	D	US-			
	E	US-			
	F	US-			
·	G	US-			
	Н	US-	, ,		
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## FOREIGN PATENT DOCUMENTS

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## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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